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International

HEXFET[®] Power MOSFET

- Surface Mount
- Available in Tape & Reel
- Dynamic dv/dt Rating
- P-Channel
- Fast Switching
- Ease of Paralleling
- · Simple Drive Requirements

Description

The HEXFET technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry and unique processing of the HEXFET design achieve very low on-state resistance combined with high transconductance and extreme device ruggedness.

The SMD-220 is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The SMD-220 is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0W in a typical surface mount application.

	Parameter	Max.	Units		
Ip @ Tc = 25°C	Continuous Drain Current, VGS @ -10 V	-1.8			
ip @ T _C = 100°C	p @ T _C = 100°C Continuous Drain Current, V _{GS} @ -10 V -1.0				
1 _{DM}	Pulsed Drain Current ①	-7.0			
P _D @ T _C = 25°C	Power Dissipation 20				
P _D @ T _A = 25°C	Power Dissipation (PCB Mount)**	3.0	— W		
	Linear Derating Factor	0.16			
	Linear Derating Factor (PCB Mount)**	0.025			
V _{GS}	Gate-to-Source Voltage	±20	V		
LM	Inductive Current, Clamp	-7.0	A		
dv/dt	Peak Diode Recovery dv/dt ③	-5.0	V/ns		
TJ, TSTG	Junction and Storage Temperature Range	-55 to +150			
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)			

Absolute Maximum Ratings

Thermal Resistance

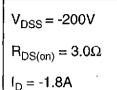
	Parameter	Min.	Тур.	Max.	Units
Reic	Junction-to-Case	—	-	6.4	
Reva	Junction-to-Ambient (PCB mount)**		—	40	°C/W
Reja	Junction-to-Ambient			62	

** When mounted on 1' square PCB (FR-4 or G-10 Material).

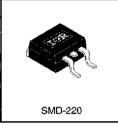
For recommended footprint and soldering techniques refer to application note #AN-994.

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Electrical C	liectrical Characteristics @ 1 J = 25°C (unless otherwise specified)							
	Parameter	Min.	Typ.	Max.	Units	Test Conditions		
V(BR)DSS	Drain-to-Source Breakdown Voltage	-200	_	_	V	V _{GS} =0V, I _D =-250μA		
ΔV _{(BR)DSS} /ΔT _J	Breakdown Voltage Temp. Coefficient	-	-0.23	_	V/⁰C	Reference to 25°C, I _D =-1mA		
R _{DS(on)}	Static Drain-to-Source On-Resistance		_	Э.О	Ω	V _{GS} =-10V, I _D =-0.90A ④		
V _{GS(th)}	Gate Threshold Voltage	-2.0	. — .	-4.0	٧	V _{DS} =V _{GS} , I _D =-250μA		
9ts	Forward Transconductance	0.90	i —	—	S	V _{DS} =-50V, I _D =-0.90A ④		
	Drain-to-Source Leakage Current			-100		V _{DS} =-200V, V _{GS} =0V		
DSS	Dialit-10-300108 Leakage Outlett		-	-500	μA	VDS=-160V, VGS=0V, TJ=125°C		
1	Gate-to-Source Forward Leakage	i —	-	-100	nA	V _{GS} =-20V		
GSS	Gate-to-Source Reverse Leakage	<u> </u>	_	100	IIA	V _{GS} =20V		
Q_g	Total Gate Charge	—		11		I _D =-3.5A		
Q _{gs}	Gate-to-Source Charge		—	7.0	nC	V _{DS} =-160V		
Q _{gd}	Gate-to-Drain ("Miller") Charge	—	_	4.0		V _{GS} =-10V See Fig. 6 and 12 @		
t _{d(on)}	Turn-On Delay Time	—	8.0	-		V _{DD} =-100V		
tr	Rise Time	—	15	_	ns	I _D =-0.90A		
t _{d(olf)}	Turn-Off Delay Time	_	10	—		$R_{G}=50\Omega$		
t _f	Fall Time	-	8.0			R₀=110Ω See Figure 10 ④		
Lo	Internal Drain Inductance	. —	4.5	. —	∙nH	Between lead, 6 mm (0.25in.)		
Ls	Internal Source Inductance	-	7.5	_	. 101	from package and center of die contact		
Ciss	Input Capacitance		170	_		V _{GS} =0V		
Coss	Output Capacitance		50	ļ	рF	Vos≖-25V		
Crss	Reverse Transfer Capacitance		15	—		f=1.0MHz. See Figure 5		

Electrical Characteristics @ TJ = 25°C (unless otherwise specified)

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Test Conditions
ls	Continuous Source Current (Body Diode)	-	_	-1.8	Α	MOSFET symbol showing the
Ism .	Pulsed Source Current (Body Diode) ①	-	_	-7.0		integral reverse p-n junction diode.
Vsd	Diode Forward Voltage	—	—	-5.8	۷	TJ=25°C, IS=-1.8A, VGS=0V ④
L _{rr}	Reverse Recovery Time	_	240	360	ns	TJ=25°C, I⊨=-1.8A
Qrr	Reverse Recovery Charge	-	1.7	2.6	μC	di/dt=100A/us ④
ton	Forward Turn-On Time	Intrinsio	Intrinsic turn-on time is neglegible (turn-on is dominated by Ls+Lp)			

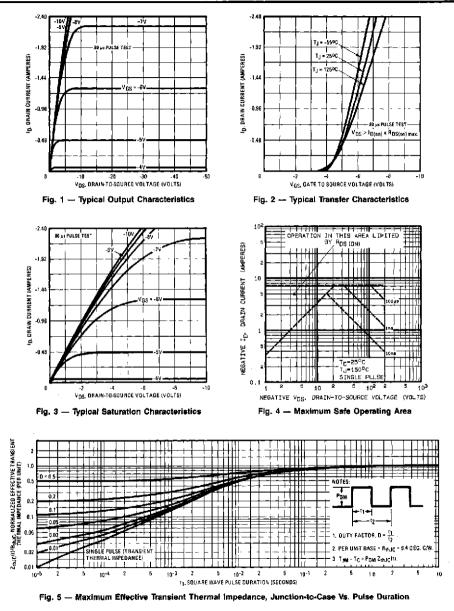
Notes:

- Bepetitive rating; pulse width limited by max, junction temperature (See Figure 11)
- ③ IsD≤-1.8A, di/dt≤70A/μs, VDD≤V(BR)DSS, TJ≤150°C

② Not Applicable

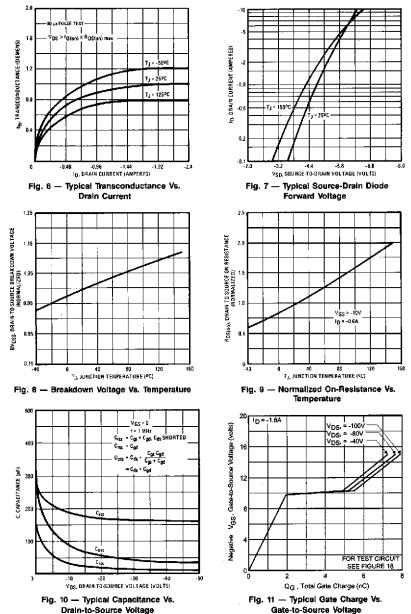
④ Pulse width \leq 300 $\mu s;$ duty cycle \leq 2%.

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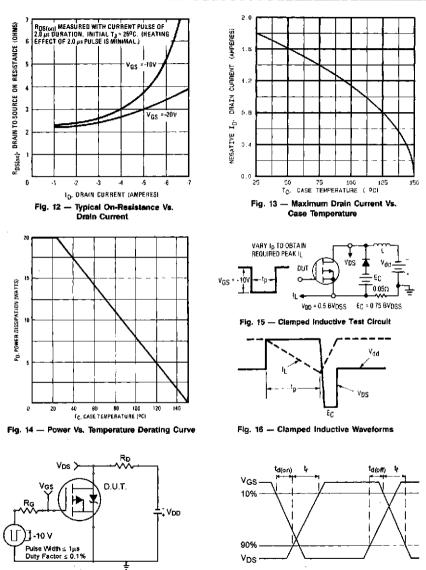
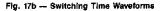
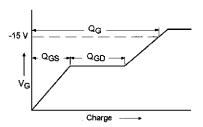


Fig. 17a — Switching Time Test Circuit





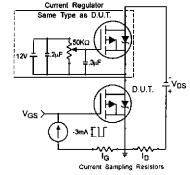




Fig. 18b - Gate Charge Test Circuit

Appendix A: Figure 14, Peak Diode Recovery dv/dt Test Circuit - See page 1506

Appendix B: Package Outline Mechanical Drawing - See page 1507

Appendix C: Part Marking Information – See page 1515

Appendix D: Tape & Reel Information - See page 1519



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